Recitation Class 4

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Outline

Chapter 6-I Nonequilibrium Excess Carriers in Semiconductors

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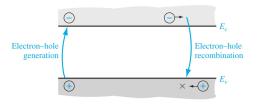
Chapter 6-I Nonequilibrium Excess Carriers in Semiconductors

Notations in Chapter 6

Table 6.1 | Relevant notation used in Chapter 6

Symbol	Definition
n_0, p_0	Thermal-equilibrium electron and hole concentrations (independent of time and also usually position)
n, p	Total electron and hole concentrations (may be functions of time and/or position)
$\delta n = n - n_0$ $\delta p = p - p_0$	Excess electron and hole concentrations (may be functions of time and/or position)
g'_n, g'_p	Excess electron and hole generation rates
R'_n, R'_p	Excess electron and hole recombination rates
$ au_{n0}, au_{p0}$	Excess minority carrier electron and hole lifetimes

Electron-hole Generation & Recombination



$$G_{n0} = G_{p0}, \quad R_{n0} = R_{p0}$$

Thermal-equilibrium

Thermal-equilibrium: the net carrier concentrations are independent of time, which means that the generation and recombination of electrons and holes are equal.

$$G_{n0} = G_{p0} = R_{n0} = R_{p0}$$

Nonequilibrium:

$$n = n_0 + \delta n$$
$$p = p_0 + \delta p$$

Note that $np \neq n_0 p_0 = n_i^2$.

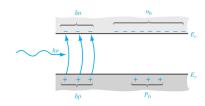


Figure: Creation of excess electron and hole densities by photons

Net Recombination Rate

n-type:

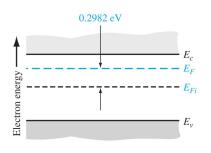
$$R_n' = R_p' = \frac{\delta p(t)}{\tau_{p0}}$$

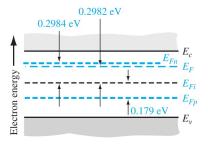
p-type:

$$R_n' = R_p' = \frac{\delta n(t)}{\tau_{n0}}$$

Quasi-Fermi Energy Level

$$n_0 + \delta n = n_i \exp\left(\frac{E_{Fn} - E_{Fi}}{kT}\right)$$
$$p_0 + \delta p = n_i \exp\left(\frac{E_{Fi} - E_{Fp}}{kT}\right)$$





Question

Why only consider minority excess carrier?

Consider the case where we have a n-type silicon semiconductor, with $n_0=10^{17}cm^{-3}$, and $p_0=n_i^2/n_0=2250cm^{-3}$. And the excess carrier $\delta n=10^{14}cm^{-3}$, which is only 0.1% of n_0 . However, $\delta p=\delta n=10^{14}cm^{-3}$, which is greatly larger than p_0 . You can also have such feeling from the Quasi-Fermi Energy Level diagram that E_{Fn} is close to E_F while E_{Fp} changes a lot.

Time-dependent Continuity Equation

$$D_{n} \frac{\mathrm{d}^{2} n}{\mathrm{d}x^{2}} + \mu_{n} \left(E \frac{\mathrm{d}n}{\mathrm{d}x} + n \frac{\mathrm{d}E}{\mathrm{d}x} \right) + g_{n} - \frac{n}{\tau_{nt}} = \frac{\mathrm{d}n}{\mathrm{d}t}$$

$$D_{p} \frac{\mathrm{d}^{2} p}{\mathrm{d}x^{2}} - \mu_{p} \left(E \frac{\mathrm{d}p}{\mathrm{d}x} + p \frac{\mathrm{d}E}{\mathrm{d}x} \right) + g_{p} - \frac{p}{\tau_{pt}} = \frac{\mathrm{d}p}{\mathrm{d}t}$$

For homogeneous semiconductor, $n(x) = n_0 + \delta n(x)$, the equation can be simplified to

$$D_{n} \frac{\mathrm{d}^{2}(\delta n)}{\mathrm{d}x^{2}} + \mu_{n} \left(E \frac{\mathrm{d}(\delta n)}{\mathrm{d}x} + n \frac{\mathrm{d}E}{\mathrm{d}x} \right) + g_{n} - \frac{n}{\tau_{nt}} = \frac{\mathrm{d}(\delta n)}{\mathrm{d}t}$$
$$D_{p} \frac{\mathrm{d}^{2}(\delta p)}{\mathrm{d}x^{2}} - \mu_{p} \left(E \frac{\mathrm{d}(\delta p)}{\mathrm{d}x} + p \frac{\mathrm{d}E}{\mathrm{d}x} \right) + g_{p} - \frac{p}{\tau_{pt}} = \frac{\mathrm{d}(\delta p)}{\mathrm{d}t}$$

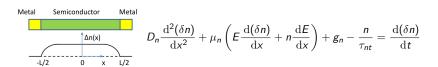
Equation Simplification

Table 6.2 | Common ambipolar transport equation simplifications

Specification	Effect
Steady state	$\frac{\partial(\delta n)}{\partial t} = 0, \frac{\partial(\delta p)}{\partial t} = 0$
Uniform distribution of excess carriers (uniform generation rate)	$D_n \frac{\partial^2(\delta n)}{\partial x^2} = 0, D_p \frac{\partial^2(\delta n)}{\partial x^2} = 0$
Zero electric field	$E \frac{\partial (\delta n)}{\partial x} = 0, E \frac{\partial (\delta p)}{\partial x} = 0$
No excess carrier generation	g'=0
No excess carrier recombination (infinite lifetime)	$\frac{\delta n}{\tau_{n0}}=0, \frac{\delta p}{\tau_{p0}}=0$

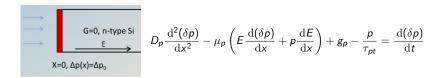
Example I

Given a piece of p-type uniformly doped semiconductor in contact with two metal electrodes separated by a length of L, forming a photoconductor device. The light illumination will create electron-hole pairs at a generation rate of g. The minority carrier recombination lifetime is τ_0 . Find the analytical distribution of the excess minority electrons at zero external bias. Note that light illumination will not create excess carriers in metals.



Example II

A light beam is illuminated on the surface of a silicon wafer, generating excess carriers Δp_0 at the surface (x=0). The wafer is placed in a constant electric field with a known intensity E. We assume there is no external generation inside the wafer. The thickness of the wafer is infinite. Find the excess minority carriers at equilibrium as a function of the distance away from the surface (x=0). Small injection condition is always maintained and the wafer is uniformly doped as N_d .



Example III

Consider a p-type semiconductor that is homogeneous and infinite in extent. Assume a zero applied electric field. For a one-dimensional crystal, assume that excess carriers are being generated at x=0 only, as indicated in Figure below. The excess carriers being generated at x=0 will begin diffusing in both the +x and -x directions. Calculate the steady-state excess carrier concentration as a function of x.

$$D_n \frac{\mathrm{d}^2(\delta n)}{\mathrm{d}x^2} + \mu_n \left(E \frac{\mathrm{d}(\delta n)}{\mathrm{d}x} + n \frac{\mathrm{d}E}{\mathrm{d}x} \right) + g_n - \frac{n}{\tau_{nt}} = \frac{\mathrm{d}(\delta n)}{\mathrm{d}t}$$

General Solutions - t

$$\frac{\mathrm{d}(\delta p)}{\mathrm{d}t} = -\frac{\delta p}{\tau_{p0}}$$

solution:

$$\delta p(t) = \delta p(0) e^{-t/\tau_{p0}}$$

$$g' - \frac{\delta p}{\tau_{p0}} = \frac{\mathrm{d}(\delta p)}{\mathrm{d}t}$$

solution:

$$\delta p(t) = g' \tau_{p0} \left(1 - e^{-t/\tau_{p0}} \right)$$

General Solutoins – x

$$D_n \frac{\mathrm{d}^2(\delta n)}{\mathrm{d}x^2} - \frac{\delta n}{\tau_{n0}} = 0$$

solution:

$$\delta n(x) = Ae^{-x/L_n} + Be^{x/L_n}, \quad L_n = \sqrt{D_n \tau_{n0}}$$

special:

$$\delta n(x) = \begin{cases} \delta n(0) e^{-x/L_n}, & x \ge 0 \\ \delta n(0) e^{+x/L_n}, & x \le 0 \end{cases}$$

-

$$D_{p} \frac{\mathrm{d}^{2} \delta p}{\mathrm{d} x^{2}} - \frac{\delta p}{\tau} + G_{\mathrm{ex}} = 0$$

solution:

$$\delta p(x) = A \exp(\lambda x) + g\tau, \quad \lambda = \pm \frac{1}{\sqrt{D_p \tau}}$$

Genral Solutions - E

$$D_{p} \frac{\mathrm{d}^{2}(\delta p)}{\mathrm{d}x^{2}} - \mu_{p} E_{0} \frac{\mathrm{d}(\delta p)}{\mathrm{d}x} - \frac{\delta p}{\tau_{p0}} = \frac{\mathrm{d}(\delta p)}{\mathrm{d}t}$$

solution:

$$\delta p(x,t) = \frac{e^{-t/\tau_{p0}}}{(4\pi D_p t)^{1/2}} \exp\left[\frac{-(x - \mu_p E_0 t)^2}{4D_p t}\right]$$

General Soluitons - E

$$D_{p}\frac{\mathrm{d}^{2}\delta p}{\mathrm{d}x^{2}} - \mu_{p}E\frac{\mathrm{d}\delta p}{\mathrm{d}x} - \frac{\delta p}{\tau} = 0$$

solution:

$$\delta p(x) = A \exp(\lambda x) + C$$

$$\lambda = \frac{L_p(E) \pm \sqrt{L_p^2(E) + 4L_p^2}}{2L_p^2}, \quad L_p = \sqrt{\tau D_p}, \quad L_p(E) = \tau \mu_p E$$

special:

$$\delta p(x) = \delta p(0) \exp \left[\frac{L_p(E) \pm \sqrt{L_p^2(E) + 4L_p^2}}{2L_p^2} x \right] = \begin{cases} \delta p(0) \exp \left(-\frac{x}{L_p} \right), & \text{if } L_p(E) \ll L_p \\ \delta p(0) \exp \left(-\frac{x}{L_p(E)} \right), & \text{if } L_p(E) \gg L_p \end{cases}$$

End